Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/829,141	KIM ET AL.
Examiner	Art Unit
Joseph Nguyen	2815

	SEAR	CHED	
Class	Subclass	Date	Examiner
257	627-628	8/4/2005	JN
257	101	8/4/2005	JN
257	e33.008	8/4/2005	JN
257	e33.003	8/4/2005	JN

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	-		

SEARCH N (INCLUDING SEARC		)
	DATE	EXMR
Search history printout	8/4/2005	ИL